Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/837,499	BECKER ET AL.
Examiner	Art Unit
EDMUND H. LEE	1732

Subclass	Date	Examiner
	1	LAAIIIIIIEI
	6/27/2006	EHL

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

DATE	EXMR
6/27/2006	EHL